### **ESD Protection Diodes**

# **Ultra Low Capacitance ESD Protection Diode for High Speed Data Line**

#### **ESDL2031**

The ESDL2031 ESD protection diodes are designed to protect high speed data lines from ESD. Ultra-low capacitance and low ESD clamping voltage make this device an ideal solution for protecting voltage sensitive high speed data lines.

#### **Features**

- Ultra Low Capacitance (0.40 pF Typ, I/O to GND)
- Protection for the Following IEC Standards: IEC 61000-4-2 (Level 4)
- Low ESD Clamping Voltage
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

#### **Typical Applications**

- USB 3.x
- MHL 2.0
- SATA/SAS
- PCI Express
- HDMI

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Operating Junction Temperature Range	TJ	-55 to +125	°C
Storage Temperature Range	T <sub>stg</sub>	-55 to +150	°C
Lead Solder Temperature – Maximum (10 Seconds)	TL	260	°C
IEC 61000-4-2 Contact (ESD) IEC 61000-4-2 Air (ESD)	ESD ESD	±30 ±30	kV kV
Maximum Peak Pulse Current 8/20 μs @ T <sub>A</sub> = 25°C	I <sub>pp</sub>	9.75	Α
Maximum Peak Pulse Power 8/20 μs @ T <sub>A</sub> = 25°C	P <sub>pk</sub>	72	W

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1

See Application Note AND8308/D for further description of survivability specs.



#### ON Semiconductor®

www.onsemi.com

#### MARKING DIAGRAM



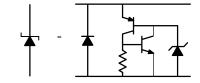
X4DFN2 (0201) CASE 152AX



J = Specific Device Code (Rotated 270 degrees)

## PIN CONFIGURATION AND SCHEMATIC





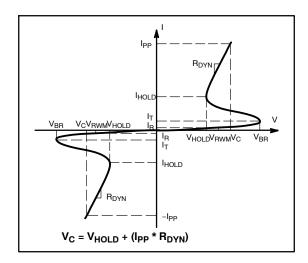
#### **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 6 of this data sheet.

#### **ELECTRICAL CHARACTERISTICS**

(T<sub>A</sub> = 25°C unless otherwise noted)

	•
Symbol	Parameter
$V_{RWM}$	Working Peak Voltage
I <sub>R</sub>	Maximum Reverse Leakage Current @ V <sub>RWM</sub>
$V_{BR}$	Breakdown Voltage @ I <sub>T</sub>
I <sub>T</sub>	Test Current
V <sub>HOLD</sub>	Holding Reverse Voltage
I <sub>HOLD</sub>	Holding Reverse Current
R <sub>DYN</sub>	Dynamic Resistance
I <sub>PP</sub>	Maximum Peak Pulse Current
V <sub>C</sub>	Clamping Voltage @ I <sub>PP</sub> V <sub>C</sub> = V <sub>HOLD</sub> + (I <sub>PP</sub> * R <sub>DYN</sub> )



#### **ELECTRICAL CHARACTERISTICS** (T<sub>A</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Reverse Working Voltage	$V_{RWM}$	I/O Pin to GND			4.0	٧
Breakdown Voltage	$V_{BR}$	I <sub>T</sub> = 1 mA, I/O Pin to GND	5.1		8.5	V
Reverse Leakage Current	I <sub>R</sub>	V <sub>RWM</sub> = 4.0 V, I/O Pin to GND			0.05	μΑ
Reverse Holding Voltage	V <sub>HOLD</sub>	I/O Pin to GND		2.5		V
Holding Reverse Current	I <sub>HOLD</sub>	I/O Pin to GND		55		mA
Clamping Voltage TLP (Note 2)	V <sub>C</sub>	$   I_{PP} = 8 \text{ A} $ $ \begin{cases}   I_{PP} = 8 \text{ A} \\ (\pm 4 \text{ kV Contact}, \pm 8 \text{ kV Air}) \end{cases} $		5.25		٧
		Ipp = 16 A		7.1		
Reverse Peak Pulse Current	I <sub>PP</sub>	per IEC61000-4-5 (8x20 μs) Figure 11	9.75			Α
Clamping Voltage 8/20 μs Waveform per Figure 11	V <sub>C</sub>	I <sub>PP</sub> = 9.75 A			7.4	٧
Dynamic Resistance	R <sub>DYN</sub>	Pin1 to Pin2 Pin2 to Pin1		0.22 0.22		Ω
Junction Capacitance	CJ	V <sub>R</sub> = 0 V, f = 1 MHz		0.40	0.55	pF

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

- 1. For test procedure see Figure 12 and application note AND8307/D.
- 2. ANSI/ESD STM5.5.1 Electrostatic Discharge Sensitivity Testing using Transmission Line Pulse (TLP) Model. TLP conditions:  $Z_0 = 50 \Omega$ ,  $t_p = 100$  ns,  $t_r = 1$  ns, averaging window:  $t_1 = 70$  ns to  $t_2 = 90$  ns.

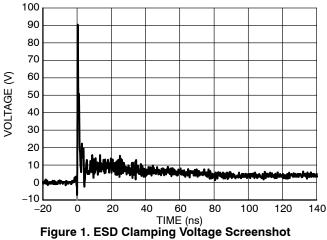
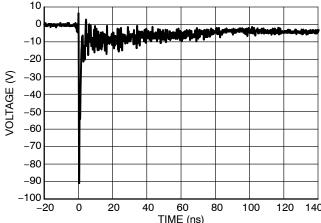


Figure 1. ESD Clamping Voltage Screenshot Positive 8 kV Contact per IEC61000-4-2



TIME (ns)
Figure 2. ESD Clamping Voltage Screenshot
Negative 8 kV Contact per IEC61000-4-2

#### **ESDL2031**

#### **TYPICAL CHARACTERISTICS**

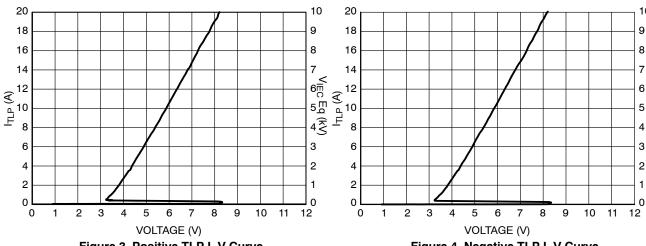


Figure 3. Positive TLP I-V Curve

Figure 4. Negative TLP I-V Curve

10

9

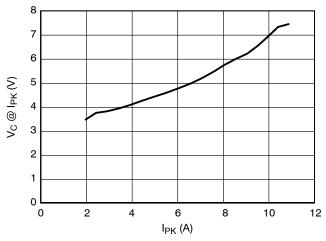


Figure 5. Positive Clamping Voltage vs. Peak Pulse Current  $(t_p = 8/20 \mu s)$ 

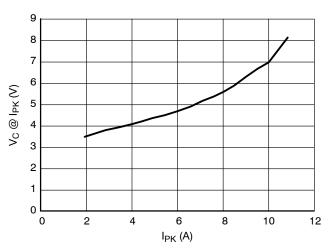


Figure 6. Negative Clamping Voltage vs. Peak Pulse Current (t<sub>p</sub> = 8/20 μs)

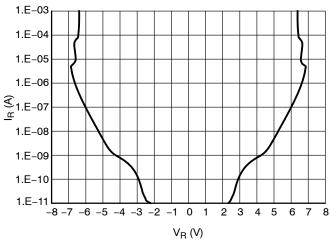


Figure 7. Breakdown Voltage

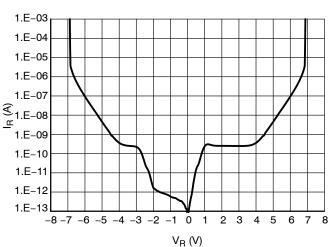


Figure 8. Reverse Leakage Current

#### **ESDL2031**

#### **TYPICAL CHARACTERISTICS**

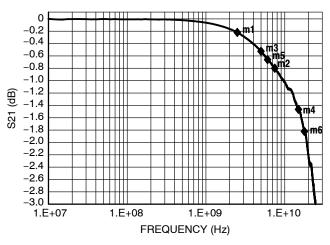


Figure 9. Insertion Loss

Interface	Data Rate (Gb/s)	Fundamental Frequency (GHz)	3 <sup>rd</sup> Harmonic Frequency (GHz)	ESDL2031 Insertion Loss (dB)
USB 3.0	5	2.5 (m1)	7.5 (m2)	m1 = -0.23 m2 = -0.81
USB 3.1	10	5.0 (m3)	15 (m4)	m3 = -0.53 m4 = -1.47
HDMI 2.1	12	6.0 (m5)	18 (m6)	m5 = -0.65 m6 = -1.82

Figure 10. ESDL2031 Insertion Loss

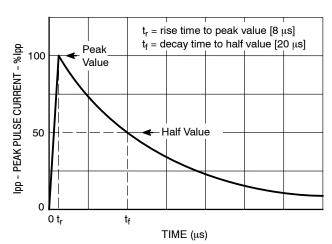


Figure 11. 8 X 20 μs Pulse Waveform

#### IEC 61000-4-2 Spec.

Level	Test Volt- age (kV)	First Peak Current (A)	Current at 30 ns (A)	Current at 60 ns (A)
1	2	7.5	4	2
2	4	15	8	4
3	6	22.5	12	6
4	8	30	16	8

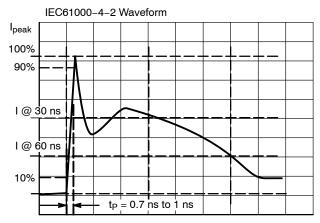


Figure 12. IEC61000-4-2 Spec

#### Transmission Line Pulse (TLP) Measurement

Transmission Line Pulse (TLP) provides current versus voltage (I–V) curves in which each data point is obtained from a 100 ns long rectangular pulse from a charged transmission line. A simplified schematic of a typical TLP system is shown in Figure 13. TLP I–V curves of ESD protection devices accurately demonstrate the product's ESD capability because the 10s of amps current levels and under 100 ns time scale match those of an ESD event. This is illustrated in Figure 14 where an 8 kV IEC 61000–4–2 current waveform is compared with TLP current pulses at 8 A and 16 A. A TLP I–V curve shows the voltage at which the device turns on as well as how well the device clamps voltage over a range of current levels.

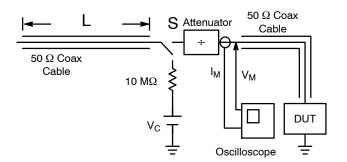


Figure 13. Simplified Schematic of a Typical TLP System

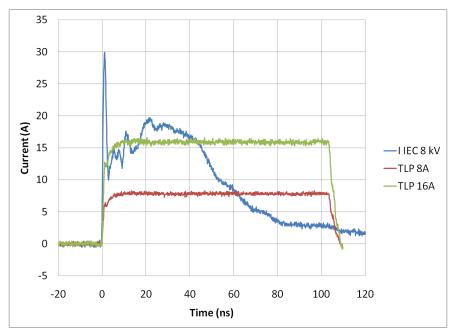


Figure 14. Comparison Between 8 kV IEC 61000-4-2 and 8 A and 16 A TLP Waveforms

#### **ESDL2031**

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
ESDL2031MX4T5G	X4DFN2 (0201) (Pb-Free)	10,000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

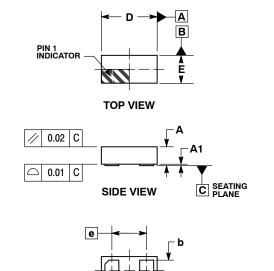


⊕ 0.05 M C

В

#### X4DFN2, 0.60x0.30, 0.36P CASE 152AX ISSUE G

**DATE 12 APR 2019** 



**BOTTOM VIEW** 

⊕ | 0.05 M | C | A | B

- NOTES:
  1. DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994.
  2. CONTROLLING DIMENSION: MILLIMETERS.

	MILLIMETERS			
DIM	MIN	NOM	MAX	
Α	0.175	0.200	0.225	
A1	0.018 REF			
b	0.205	0.215	0.225	
D	0.575	0.600	0.625	
Е	0.275	0.300	0.325	
е	0.36 BSC			
L	0.145	0.155	0.165	

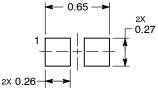
#### **GENERIC MARKING DIAGRAM\***



#### X = Specific Device Code

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G", may or not be present. Some products may not follow the Generic Marking.

#### **RECOMMENDED SOLDER FOOTPRINT\***



DIMENSIONS: MILLIMETERS

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

DOCUMENT NUMBER:	98AON06808G	Electronic versions are uncontrolled except when accessed directly from the Document Repositor Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.	
DESCRIPTION:	X4DFN2, 0.60x0.30, 0.36P		PAGE 1 OF 1

ON Semiconductor and (III) are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.

onsemi, ONSEMI, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at <a href="www.onsemi.com/site/pdf/Patent-Marking.pdf">www.onsemi.com/site/pdf/Patent-Marking.pdf</a>. Onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any EDA class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer pu

#### **PUBLICATION ORDERING INFORMATION**

LITERATURE FULFILLMENT: Email Requests to: orderlit@onsemi.com

onsemi Website: www.onsemi.com

TECHNICAL SUPPORT North American Technical Support: Voice Mail: 1 800-282-9855 Toll Free USA/Canada Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support:

Phone: 00421 33 790 2910

For additional information, please contact your local Sales Representative